
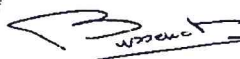

		<b>APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL</b>			Page 1 Appl. No.
Component Title: Transistor Bipolar NPN low and high power		Executive Member: CNES			Date: 25/07/2016 233L
Components (including series and families) submitted for Extension of Qualification Approval:					1
ESCC COMPONENT NO.	VARIANTS	RANGE OF COMPONENTS	BASED ON	TEST VEHICLE / S	COMPONENT SIMILAR
5201/001	01, 02, 04, 05, 06, 07	TO-18, LCC3, LCC3+1	2N2484		
5201/002	01, 02, 04, 05, 11, 12	TO-18, LCC3, LCC3+1	2N2222A	Lot ID33420004ZZ	
5201/003 5201/004 *****	01, 02 01, 02, 04, 05, 06, 07 *****	TO39 TO-18, LCC3, LCC3+1 *****	2N2219A 2N3700 *****	***** Lot ID33510009ZY *****	
55201/011	03, 04	TO-39	2N3019		
5201/019 *****	01, 02, 04, 05, 08, 09 *****	TO-18, LCC3, LCC3+1 *****	2N5551 *****	***** *****	
5203/010	01, 02, 04, 05, 06, 07	TO39, TO-257, SMD0.5	2N5154	Lot ID33307002ZH	
5203/016	06, 07	TO257	BUX77ESY		
5207/002	03, 06, 12, 15, 16, 17	TO-77, LCC6, FP-8D	2N2920A		
Component Manufacturer STMicroelectronics		Location of Manufacturing Plant(s) 3, rue de Suisse BP4199, 35041 Rennes Cedex		Date of original qualification approval: Date: 02/09/1996  Certificate Ref No. 233	
ESCC Specifications used for Maintenance of qualification testing: Generic: 5000 Issue: 3  Detail(s): 5201/001 Issue: 6 5201/002           8 5201/003           4 5201/004           6 5201/011           4 5201/019           6 5203/010           6 5203/016           3 5207/002           6		Deviations to LVT testing and Detail Specification used: No <input checked="" type="checkbox"/> Yes <input type="checkbox"/> (supply details in Box 15)  Deviation from current Specifications:   No <input checked="" type="checkbox"/> Yes <input type="checkbox"/> (Supply details)		Qualification Extension Report reference and date: RNS/AN/16-153-01/ce 1 <sup>st</sup> June 2016	
Summary of procurement or equivalent test results during current validity period in support of this application (those to ESCC listed first)					
Project Name	Testing Level	LAT	Date code	Quantity Delivered	
TAS ETCA			1416, 1421A, 1451A, 1505A, 1513A...		
EBV			1419A, 1444B, 1506A, 1608A...		
Alter Spain			1445A, 1448A, 1504A, 1507A...		
TESAT Spacecom			1504A, 1507A, 1525A...		
PID changes since start of qualification None <input type="checkbox"/> Minor* <input checked="" type="checkbox"/> Major* <input type="checkbox"/> *Provide details in box:			Current PID Verified by: CNES Name of Executive Representative Ref No: 8097046 (generic) Rev 15 and 8124528 (specific Bipolar) rev 16 Issue: Date: 10/03/2016 Rev Date:		
Current Manufacturing facilities surveyed by: ESA & CNES on 27/11/2014 (Name of Executive Representative) (Date)  Satisfactory: Yes <input checked="" type="checkbox"/> No <input type="checkbox"/> Explain  Report Reference: ESA-TECQES-RP-0559 issue 1, 19/12/2014					

	<p align="center"><b>APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL</b></p> <p>Component title: Transistor Bipolar NPN low and high power</p> <p>Executive Member: CNES Date: 25/07/2016</p>		<p>Page 2</p> <p>Appl. No. 233L</p>
<p>Failure Analysis, DPA, NCCS available:    Yes    <input type="checkbox"/>    No    <input checked="" type="checkbox"/>    (Supply data)</p> <p>Ref. No's and purposes:</p>			<p>12</p>
<p>The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; - that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence (except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of CNES as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein.</p> <p>Date: 29/07/2016</p> <p align="right">   <u>JP. BUSSENOT</u>          (Signature of the Executive Coordinator)       </p>			<p>13</p>
<p>Continuation of Boxes above:</p> <p>Box 7:</p> <p>2N3700RHRG Lot ID33440002ZV DC1505A : covers TO18 packages          2N5153YHRB Lot ID3315000BZM DC1435A : covers TO257 packages          2N3810RHRG Lot ID33343005ZZ DC1412C : covers TO77/TO78 packages          2N3810KT Lot ID33301003XD DC1412A : covers FLAT8 packages          2N5153HRG Lot ID3312518501 DC1507A : covers TO39 packages</p>			<p>14</p>

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Component title: Transistor Bipolar NPN low and high power Executive Member: CNES		Date: 25/07/2016

Non compliance to ESCC requirements: 15

No.:	Specification	Paragraph	Non compliance

Additional tasks required to achieve full compliance for ESCC qualification or rationale for acceptability of noncompliance: 16


Executive Manager Disposition 17


Application Approval:    Yes    ☒    No    ☐

Action / Remarks:

ESCC EXECUTIVE SURVEY OF ST'S NEW CLEAN ROOM FOR  
 ASSEMBLY AND TEST AT THEIR RENNES SITE IS  
 SCHEDULED FOR 29-30 AUGUST.

Date:

  
 \_\_\_\_\_  
 Signature, ESA Representative

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**ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION**

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Tests conducted in compliance with:

- ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts);
- or PID-TFD (for ESCC/QML parts)


Tests vehicle identification/description:


SOC2222AHRG Lot ID33420004ZZ DC1430A	Full Chart F4
SOC3700HRG Lot ID33510009ZY DC1527A	Full Chart F4
2N5154SHR Lot ID33307002ZH DC1413B	Full Chart F4

Detail Specification reference: 5201/002/004 & 5203/010

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
Environmental/Mechanical Subgroup	Mechanical shock	<input checked="" type="checkbox"/>	MIL-STD-750 TM2016	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Vibration	<input checked="" type="checkbox"/>	MIL-STD-750 TM2056	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Constant acceleration	<input checked="" type="checkbox"/>	MIL-STD-750 TM2006	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Seal Fine leak Gross leak	<input checked="" type="checkbox"/>	MIL-STD-750 TM1071	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Electrical Measurement	<input checked="" type="checkbox"/>	Intermediate and End-Point Electrical Measurements	1430A + 1527A + 1413B	15 + 15 + 15	0	
	External Visual	<input checked="" type="checkbox"/>	ESCC Basic Spec 20500	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Thermal shock	<input type="checkbox"/>	MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
	Temperature Cycling	<input checked="" type="checkbox"/>	MIL-STD-750 TM1051	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Moisture Resistance	<input checked="" type="checkbox"/>	MIL-STD-750 TM1021	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Seal Fine leak Gross leak	<input checked="" type="checkbox"/>	MIL-STD-750 TM1071	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Electrical Measurement	<input checked="" type="checkbox"/>	Intermediate and End-Point Electrical Measurements	1430A + 1527A + 1413B	15 + 15 + 15	0	
	External Visual	<input checked="" type="checkbox"/>	ESCC Basic Spec 20500	1430A + 1527A + 1413B	15 + 15 + 15	0	
Endurance Subgroup	Operating Life	<input checked="" type="checkbox"/>	ESCC 5000 Para. 8.19	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Electrical Measurement	<input checked="" type="checkbox"/>	Intermediate and End-Point Electrical Measurements	1430A + 1527A + 1413B	15 + 15 + 15	0	
	Seal Fine leak Gross leak	<input checked="" type="checkbox"/>	MIL-STD-750 TM1071	1430A + 1527A + 1413B	15 + 15 + 15	0	
	External Visual Inspection	<input checked="" type="checkbox"/>	ESCC Basic Spec 20500	1430A + 1527A + 1413B	15 + 15 + 15	0	
Assembly Capability Subgroup	Permanence of Marking	<input type="checkbox"/>	ESCC Basic Spec 24800				Not applicable on Laser marking
	Terminal Strength	<input checked="" type="checkbox"/>	ESCC 5000 Para. 8.18	1430A + 1527A + 1413B	5 + 5 + 5	0	
	Internal Visual	<input checked="" type="checkbox"/>	ESCC Basic Spec 20400	1430A + 1527A + 1413B	5 + 5 + 5	0	
	Bond Strength	<input checked="" type="checkbox"/>	MIL-STD-750 TM 2037	1430A +	3 + 3 + 3	0	

				1527A + 1413B			
	Die Shear	<input checked="" type="checkbox"/>	MIL-STD-750 TM 2017	1430A + 1527A + 1413B	3 + 3 + 3	0	

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							233L
Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
Additional Tests		<input type="checkbox"/>					
		<input type="checkbox"/>					
		<input type="checkbox"/>					

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<p align="center"><b>NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL</b></p>		
<p><b>ENTRIES</b> Form heading</p>	<p>shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.</p>	
<p><b>Box 1</b></p>	<p>shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.</p>	
<p><b>Box 2; 3 and 4</b></p>	<p>As per QPL entry; otherwise, an explanation of the changes must be supplied.</p>	
<p><b>Box 5</b></p>	<p>Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.</p>	
<p><b>Box 6</b></p>	<p>Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.</p>	
<p><b>Box 7</b></p>	<p>Must reference the report(s) supplied in support of the application.</p>	
<p><b>Box 8</b></p>	<p>Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.</p>	
<p><b>Box 9</b></p>	<p>If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.</p>	
<p><b>Box 10</b></p>	<p>Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.</p>	
<p><b>Box 11</b></p>	<p>This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.</p>	
<p><b>Box 12</b></p>	<p>Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.</p>	
<p><b>Box 13</b></p>	<p>Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.</p>	
<p><b>Box 14</b></p>	<p>To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.</p>	
<p><b>Box 15</b></p>	<p>Fill in Table as requested.</p>	
<p><b>Box 16</b></p>	<p>Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.</p>	
<p><b>Box 17</b></p>	<p>All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.</p>	
<p><b>Box 18</b></p>	<p>Fill in Table as requested.</p>	
<p><b>Box 19</b></p>	<p>Confidential Details of PID changes including those of a confidential nature, shall be provided.</p>	
<p><b>Box 20</b></p>	<p>State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.</p>	
<p><b>Box 21</b></p>	<p>Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.</p>	
<p><b>Box 22</b></p>	<p>Additional Comments.</p>	